

Notice of References Cited	Application/Control No. 10/670,212	Applicant(s)/Patent Under Reexamination NAKAYAMA ET AL.	
	Examiner Matthew D. Matzek	Art Unit 1771	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,838,172	01-2005	Yoon et al.	428/370
	C	US-6,733,859	05-2004	Yoneda et al.	428/91
	D	US-5,969,015	10-1999	Zinke et al.	524/109
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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